

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SHIN ET AL.	
		Examiner JULIO PEREZ	Art Unit 2617	Page 1 of 1

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*	B	US-2005/0032494 A1	02-2005	Swant, John M.	455/226.1
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NON-PATENT DOCUMENTS

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